Notice of References Cited

| Application/Control No. 09/762,387 | Reexamination | Applicant(s)/Patent Under Reexamination SHINOHARA ET AL. | | |
|------------------------------------|---------------|--|--|--|
| Examiner | Art Unit | | | |
| Jean W. Désir | 2614 | Page 1 of 2 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------|
| | Α | US-5,701,581 | 12-1997 | Eto et al. | 348/14.13 |
| | В | US-5,990,967 A | 11-1999 | Kawakami et al. | 348/500 |
| | С | US-6,313,863 B1 | 11-2001 | Chida, Makoto | 348/14.01 |
| | D | US-6,438,165 B2 | 08-2002 | Normile, James Oliver | 375/240 |
| | Е | US-5,867,626 A | 02-1999 | Kawakami et al. | 386/108 |
| | F | US-5,646,941 | 07-1997 | Nishimura et al. | 370/389 |
| | G | US-6,580,451 B2 | 06-2003 | Yonezawa et al. | 348/159 |
| | Н | US-6,133,941 A | 10-2000 | Ono, Eita | 348/14.05 |
| | 1 | US-6,208,376 B1 | 03-2001 | Tanaka et al. | 348/153 |
| | J | US-6,275,537 B1 | 08-2001 | Lee, Sang-jin | 375/240.28 |
| | к | US-6,014,765 A | 01-2000 | Maeda et al. | 714/748 |
| | L | US-6,516,002 B1 | 02-2003 | Huang et al. | 370/468 |
| | М | US-5,365,265 A | 11-1994 | Shibata et al. | 348/14.1 |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | • | | | | |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
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| | х | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. 09/762,387 Applicant(s)/Patent Under Reexamination SHINOHARA ET AL. Examiner Jean W. Désir Art Unit Page 2 of 2

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | Α | US-5,535,208 A | 07-1996 | Kawakami et al. | 370/391 |
| | В | US- | | | |
| | С | US- | | | |
| • | D | US- | | | |
| | Е | US- | | | |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | | - |
| | l | US- | | | |
| | J | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | |
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| | ٧ | | | | |
| | W | | | | |
| | x | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.